

AMENDMENT UNDER 37 CFR 1.116-EXPEDITED PROCEDURE-EXAMINING

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of

Takashi NIWA et al.

Serial No. 09/740,664 : Group Art Unit: 2878

Filed: December 19, 2000

For: NEAR-FIELD OPTICAL PROBE : Examiner - Thanh X. Luu

HAVING CANTILEVER AND PROBE FORMED OF TRANS-PARENT MATERIAL, METHOD FOR MANUFACTURING NEAR-FIELD OPTICAL PROBE, AND : OPTICAL APPARATUS HAVING

NEAR-FIELD OPTICAL

PROBE (As Amended) : Docket No. S004-4168

MS AF COMMISSIONER FOR PATENTS P.O. BOX 1450 ALEXANDRIA, VA 22313-1450

> AMENDMENT AFTER FINAL UNDER RULE 116

S I R:

In response to the Office Action dated September 16, 2003, applicants amend their application as follows:

ADDITIONAL FEES:

No additional fees are believed required in connection with this amendment after final; however, should it be determined that a fee is due, authorization is hereby given to charge any such fee to our Deposit Account No. 01-0268.

> MAILING CERTIFICATE ON LAST PAGE